* * * * *	* *	* *	* Welcome to STN International * * * * * * * * *
NEWS 1			Web Page URLs for STN Seminar Schedule - N. America
NEWS 2			"Ask CAS" for self-help around the clock
NEWS 3	Feb	24	PCTGEN now available on STN
NEWS 4	Feb	24	TEMA now available on STN
NEWS 5	Feb	26	NTIS now allows simultaneous left and right truncation
NEWS 6	Feb	26	
NEWS 7	Mar	04	SDI PACKAGE for monthly delivery of multifile SDI results
NEWS 8	Mar	24	PATDPAFULL now available on STN
NEWS 9	Mar	24	Additional information for trade-named substances without
			structures available in REGISTRY
NEWS 10	Apr		
NEWS 11	Apr		
NEWS 12	Apr		
NEWS 13	AUG		Indexing from 1927 to 1936 added to records in CA/CAPLUS
NEWS 14	Apr	21	New current-awareness alert (SDI) frequency in
		~ ~	WPIDS/WPINDEX/WPIX
NEWS 15	Apr		
NEWS 16	May	05	-
אוריזעולו זיי	Mass	1 -	added to PHAR
NEWS 17 NEWS 18	May May		
NEWS 19	May		
NEWS 20	_	19	_
115115 20	May	10	right truncation
NEWS 21	Jun	06	J contract the contract contra
NEWS 22	Jun		<u> </u>
NEWS 23		20	
NEWS 24		25	
NEWS 25	Jul		
NEWS 26		21	
NEWS 27	Jul	21	and the contract of the contra
NEWS 28	Jul	22	INPADOC: Basic index (/BI) enhanced; Simultaneous Left and
			Right Truncation available
NEWS 29	AUG	05	
			August 1, 2003
NEWS 30			Field Availability (/FA) field enhanced in BEILSTEIN
NEWS 31	AUG	15	_
			September 2003
NEWS 32	AUG	15	· · ·
			September 2003
NEWS 33	AUG	15	RDISCLOSURE: one FREE connect hour, per account, in
NUMBER OF	7.110	1 -	September 2003
NEWS 34	AUG	12	TEMA: one FREE connect hour, per account, in September 2003
NEWS 35	אווכ	10	Data available for download as a PDF in RDISCLOSURE
NEWS 36	AUG		
NEWS 37		18	
112112 37	AUG	10	Truncation
NEWS 38	AHG	18	Simultaneous left and right truncation added to ANABSTR
			D2
NEWS EXPRESS April 4 CURRENT WINDOWS VERSION IS V6.01a, CURRENT			
*****			CINTOSH VERSION IS V6.0b(ENG) AND V6.0Jb(JP),
		ANI	CURRENT DISCOVER FILE IS DATED 01 APRIL 2003
		ST	N Operating Hours Plus Help Desk Availability
			neral Internet Information
NEWS LOGIN			clcome Banner and News Items
NEWS PHONE			rect Dial and Telecommunication Network Access to STN
NEWS WWW		CA	S World Wide Web Site (general information)

Enter NEWS followed by the item number or name to see news on that specific topic.

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FILE 'HOME' ENTERED AT 13:54:42 ON 25 AUG 2003

=> file inspec

COST IN U.S. DOLLARS

SINCE FILE TOTAL ENTRY SESSION 0.21 0.21

FULL ESTIMATED COST

FILE 'INSPEC' ENTERED AT 13:54:54 ON 25 AUG 2003 Compiled and produced by the IEE in association with FIZ KARLSRUHE COPYRIGHT 2003 (c) INSTITUTION OF ELECTRICAL ENGINEERS (IEE)

FILE LAST UPDATED: 18 AUG 2003 FILE COVERS 1969 TO DATE. <20030818/UP>

<>< SIMULTANEOUS LEFT AND RIGHT TRUNCATION AVAILABLE IN

=> poram

PCRAM IS NOT A RECOGNIZED COMMAND

THE BASIC INDEX >>>

The previous command name entered was not recognized by the system. For a list of commands available to you in the current file, enter "HELP COMMANDS" at an arrow prompt (=>).

=> 2 param

L1 0 PCRAM

=> s chalcogenide

L2 8804 CHALCOGENIDE

=> 8 dram

L3 6005 DRAM

=> s 12 and 13

L4 2 L2 AND L3

=> d 14 1-2

L4 ANSWER 1 OF 2 INSPEC (C) 2003 IEE on STN



AN 2001:6993617 INSPEC DN B2001-09-1265D-006

TI Now in Italy-a new technology for thin film non-volatile memory.

AU Devittor, P.

SO Elettronica Oggi (June 2001) no.302, p.39-42. 0 refs.

Published by: Gruppo Editoriale Jackson

CODEN: ELOGDA ISSN: 0391-6391 SICI: 0391-6391(200106)302L.39:ITTF;1-3

DT Journal

TC New Development; Experimental

CY Italy

LA Italian

L4 ANSWER 2 OF 2 INSPEC (C) 2003 IEE on STN



AN 2000:6795679 INSPEC DN B2001-02-1265D-013; C2001-02-5320G-011 TI Nonvolatile, high density, high performance phase-change memory.

AU Tyson, S. (Mission Res. Corp., Albuquerque, NM, USA); Wicker, G.; Lowrey, T.; Hudgens, S.; Hunt, K.

SO 2000 IEEE Aerospace Conference. Proceedings (Cat. No.00TH8484) Piscataway, NJ, USA: IEEE, 2000. p.385-90 vol.5 of 7 vol.(xxviii+566+524+512+566+554+586+686) pp. 19 refs.

Conference: Big Sky, MT, USA, 18-25 March 2000 Sponsor(s): IEEE Aerosp. & Electron. Syst. Soc

Price: CCCC 0 7803 5846 5/2000/\$10.00

ISBN: 0-7803-5846-5 DT Conference Article

TC Practical; Theoretical; Experimental

CY United States

LA English

=> log y

COST IN U.S. DOLLARS SINCE FILE TOTAL

ENTRY SESSION

FULL ESTIMATED COST 6.78 6.99

STN INTERNATIONAL LOGOFF AT 13:56:16 ON 25 AUG 2003